## Product Preview MOSFET Driver

The NCP81155 is a high-performance dual MOSFET gate driver in a small 3 mm x 3 mm package, optimized to drive the gates of both high-side and low-side power MOSFETs in a buck or buck-boost application. VCC UVLO ensures the MOSFETs are off when supply voltages are low. A bi-directional Enable pin provides a fault signal to the controller when a UVLO fault is detected.

#### Features

- Space–Efficient 3 mm x 3 mm DFN8 Thermally–Enhanced Package
- VCC Range of 4.5 V to 13.2 V
- Integrated Bootstrap Diode
- Compatible with 3.3 V and 5 V PWM Inputs
- Bi–Directional Enable Feature Pulls Enable Pin low during a UVLO Fault.
- Adaptive Anti-Cross Conduction Circuit Protects against Cross-Conduction during FET Turn-on and Turn-off
- Output Disable Control Turns Off Both MOSFETs
- VCC Undervoltage Lockout
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

#### **Typical Applications**

- E-Cigarettes
- Unmanned Aerial Vehicles (UAV)

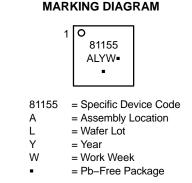


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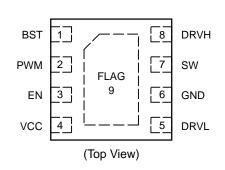
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DFN8 MN SUFFIX CASE 506BJ



(Note: Microdot may be in either location)



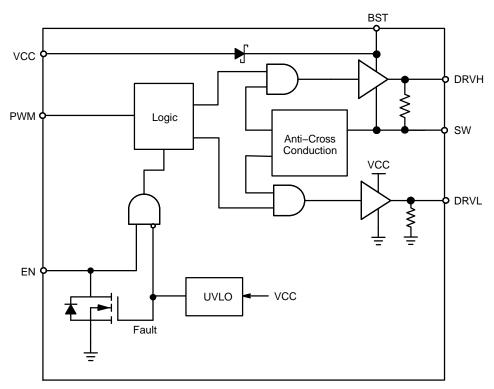
### **PIN CONNECTIONS**

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NCP81155MNTXG	DFN8 (Pb–Free)	3000 / Tape & Reel

<sup>+</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

This document contains information on a product under development. ON Semiconductor reserves the right to change or discontinue this product without notice.





#### **Table 1. Pin Descriptions**

Pin No.	Symbol	Description
1	BST	Floating bootstrap supply pin for high side gate driver. Connect the bootstrap capacitor between this pin and the SW pin.
2	PWM	Control input: PWM = High – DRVH is high, DRVL is low. PWM = Low – DRVH is low, DRVL is high.
3	EN	Enable input: EN = High – Driver is enabled. EN = Low – Driver is disabled.
4	VCC	Power supply input. Connect a bypass capacitor (0.1 $\mu$ F) from this pin to ground.
5	DRVL	Low side gate drive output. Connect to the gate of low side MOSFET.
6	GND	Bias and reference ground. All signals are referenced to this node (QFN Flag).
7	SW	Switch node. Connect this pin to the source of the high side MOSFET and drain of the low side MOSFET.
8	DRVH	High side gate drive output. Connect to the gate of high side MOSFET.
9	FLAG	Thermal flag. There is no electrical connection to the IC. Connect to ground plane.

## **Table 2. ABSOLUTE MAXIMUM RATINGS**

Pin Symbol	Pin Name	V <sub>MAX</sub>	V <sub>MIN</sub>
VCC	Main Supply Voltage Input	15 V 16 V (< 50 ns)	-0.3 V
BST	Bootstrap Supply Voltage	35 V wrt/ GND 40 V ≤ 50 ns wrt/ GND 15 V wrt/ SW	–0.3 V wrt/SW
SW	Switching Node (Bootstrap Supply Return)	35 V 40 V ≤ 50 ns	−5 V −10 V (200 ns)
DRVH	High Side Driver Output	BST+0.3 V SW + 15 V (< 80 ns)	–0.3 V wrt/SW −2 V (<200 ns) wrt/SW
DRVL	Low Side Driver Output	VCC+0.3 V 15 V (< 80 ns)	–0.3 V DC −5 V (<200 ns)
PWM	DRVH and DRVL Control Input	6.5 V	–0.3 V
EN	Enable Pin	6.5 V	–0.3 V
GND	Ground	0 V	0 V

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

Table 3. THERMAL INFORMATION (A	All signals referenced to AGND unless noted otherwise)
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Symbol	Parameter	Value	Unit
$R_{ extsf{ heta}JA}$	R <sub>0JA</sub> Thermal Characteristic (Note 1)		°C/W
TJ	Operating Junction Temperature Range	-40 to 125	°C
T <sub>A</sub>	Operating Ambient Temperature Range	-10 to +125	°C
T <sub>STG</sub>	Maximum Storage Temperature Range	-55 to +150	°C
MSL	Moisture Sensitivity Level	1	

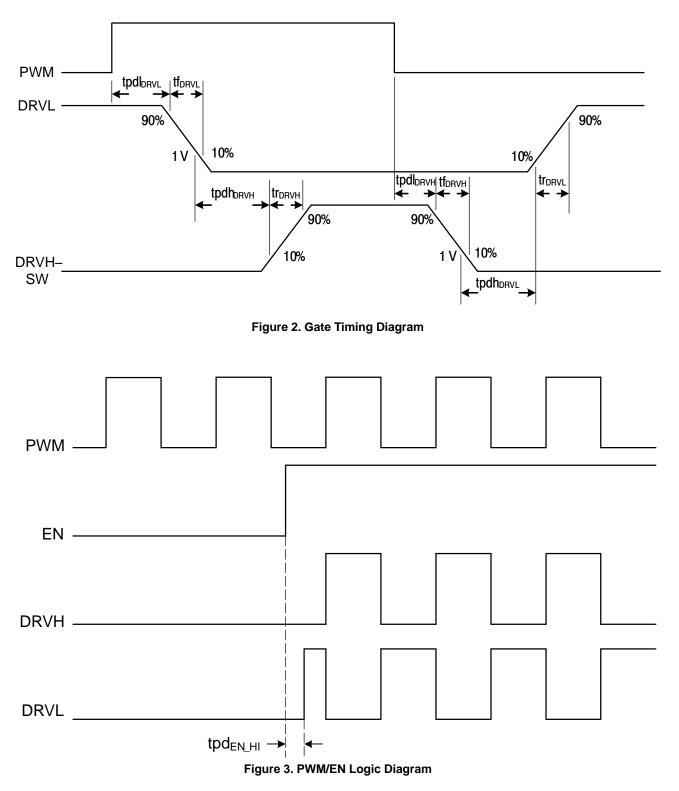
\* The maximum package power dissipation must be observed.
1. I in<sup>2</sup> Cu, 1 oz thickness.

# **Table 4. ELECTRICAL CHARACTERISTICS** (Unless otherwise stated: $-10^{\circ}C < T_A < +125^{\circ}C$ ; 4.5 V < $V_{CC} < 13.2$ V,4.5 V < BST-SWN < 13.2 V, 4.5 V < BST < 30 V, 0 V < SWN < 21 V)</td>

Parameter	Test Conditions	Min.	Тур.	Max.	Units
SUPPLY VOLTAGE	•				•
VCC Operation Voltage		4.5		13.2	V
UNDERVOLTAGE LOCKOUT		•	•		
VCC Start Threshold		3.8	4.35	4.5	V
VCC UVLO Hysteresis		150	200	250	mV
SUPPLY CURRENT			1		1
Normal Mode	Icc + Ibst, EN = 5 V, PWM = OSC, Fsw = 100 KHz, Cload = 3 nF for DRVH, 3 nF for DRVL		10		mA
Standby Current	Icc + Ibst, EN = GND		0.5	1.4	mA
Standby Current	I <sub>CC</sub> + I <sub>BST</sub> , EN = HIGH, PWM = LOW, No loading on DRVH & DRVL		2.0		mA
Standby Current	I <sub>CC</sub> + I <sub>BST</sub> , EN = HIGH, PWM = HIGH, No loading on DRVH & DRVL		2.0		mA
BOOTSTRAP DIODE	-				•
Forward Voltage	$V_{CC}$ = 12 V, forward bias current = 2 mA	0.1	0.4	0.6	V
PWM INPUT					•
PWM Input High		2.0			V
PWM Input Low				0.8	V
HIGH SIDE DRIVER (VCC = 12 V)					•
Output Impedance, Sourcing Current	VBST – VSW = 12 V		1.9	3.0	Ω
Output Impedance, Sinking Current	VBST – VSW = 12 V		1.0	1.7	Ω
DRVH Rise Time trdRVH	V <sub>VCC</sub> = 12 V, 3 nF load, VBST–VSW = 12 V		16	30	ns
DRVH Fall Time tfDRVH	V <sub>VCC</sub> = 12 V, 3 nF load, VBST–VSW = 12 V		11	25	ns
DRVH Turn–Off Propagation Delay tpdl <sub>DRVH</sub>	$C_{LOAD} = 3 \text{ nF}$	8	13	30	ns
DRVH Turn–On Propagation Delay tpdh <sub>DRVH</sub>	$C_{LOAD} = 3 \text{ nF}$			30	ns
DRVH Pull Down Resistance	DRVH to SW, BST-SW = 0 V		37.5		kΩ
HIGH SIDE DRIVER (VCC = 5 V)					
Output Impedance, Sourcing Current	VBST – VSW = 5 V		2.5		Ω
Output Impedance, Sinking Current	VBST – VSW = 5 V		1.6		Ω
DRVH Rise Time tr <sub>DRVH</sub>	V <sub>VCC</sub> = 5 V, 3 nF load, VBST – VSW = 5 V		30		ns
DRVH Fall Time tf <sub>DRVH</sub>	V <sub>VCC</sub> = 5 V, 3 nF load, VBST – VSW = 5 V		27		ns
DRVH Turn–Off Propagation Delay tpdl <sub>DRVH</sub>	$C_{LOAD} = 3 \text{ nF}$		20		ns
DRVH Turn–On Propagation Delay tpdh <sub>DRVH</sub>	$C_{LOAD} = 3 \text{ nF}$		27		ns
SW Pull Down Resistance	SW to PGND	1	37.5		kΩ
LOW SIDE DRIVER (VCC = 12 V)		1	1	1	
Output Impedance, Sourcing Current			2.0	3.0	Ω
Output Impedance, Sinking Current		1	0.7	1.5	Ω
DRVL Rise Time tr <sub>DRVL</sub>	$C_{LOAD} = 3  \text{nF}$		16	35	ns
DRVL Fall Time tf <sub>DRVL</sub>	$C_{LOAD} = 3 \text{ nF}$		11	20	ns

Table 4. ELECTRICAL CHARACTERISTICS (Unless otherwise stated: $-10^{\circ}C < T_A < +125^{\circ}C$ ; 4.5 V < V <sub>CC</sub> < 13.2 V,	
4.5 V < BST-SWN < 13.2 V, 4.5 V < BST < 30 V, 0 V < SWN < 21 V)	

Parameter	Test Conditions	Min.	Тур.	Max.	Units
LOW SIDE DRIVER (VCC = 12 V)		ł	•		
DRVL Turn–Off Propagation Delay tpdl <sub>DRVL</sub>	C <sub>LOAD</sub> = 3 nF		15	35	ns
DRVL Turn–On Propagation Delay tpdh <sub>DRVL</sub>	C <sub>LOAD</sub> = 3 nF	8.0		30	ns
DRVL Pull Down Resistance	DRVL to PGND, VCC = PGND		37.5		kΩ
LOW SIDE DRIVER (VCC = 5 V)		•			•
Output Impedance, Sourcing Current			2.5		Ω
Output Impedance, Sinking Current			1.0		Ω
DRVL Rise Time tr <sub>DRVL</sub>	$C_{LOAD} = 3 \text{ nF}$		30		ns
DRVL Fall Time tf <sub>DRVL</sub>	$C_{LOAD} = 3 \text{ nF}$		22		ns
DRVL Turn–Off Propagation Delay tpdl <sub>DRVL</sub>	C <sub>LOAD</sub> = 3 nF		22		ns
DRVL Turn–On Propagation Delay tpdh <sub>DRVL</sub>	C <sub>LOAD</sub> = 3 nF		12		ns
DRVL Pull Down Resistance	DRVL to PGND, VCC = PGND		37.5		kΩ
EN INPUT		•			•
Input Voltage High		2.0			V
Input Voltage Low				1.0	V
Hysteresis			500		mV
Normal Mode Bias Current		-1		1	μΑ
Enable Pin Sink Current		4		30	mA
Propagation Delay Time	PWM = 0 V, EN going from 0 V to EN <sub>HI</sub> to DRVL rising to 10%		20	40	ns
SW Node	·	·	•		
SW Node Leakage Current				20	μΑ



#### APPLICATIONS INFORMATION

The NCP81155 gate driver is a MOSFET driver designed for driving two N-channel MOSFETs in a synchronous buck or buck-boost topology.

#### Low-Side Driver

The low-side driver is designed to drive a ground referenced low  $R_{DS(on)}$  N-channel MOSFET. The voltage supply for the low-side driver is internally connected to the VCC and GND pins.

#### **High-Side Driver**

The high–side driver is designed to drive a floating low  $R_{DS(on)}$  N–channel MOSFET. The gate voltage for the high–side driver is developed by a bootstrap circuit referenced to the SW pin.

The bootstrap circuit is comprised of the integrated diode and an external bootstrap capacitor. When the NCP81155 is starting up, the SW pin is held at ground, allowing the bootstrap capacitor to charge up to VCC through the bootstrap diode. When the PWM input is driven high, the high–side driver will turn on the high–side MOSFET using the stored charge of the bootstrap capacitor. As the high–side MOSFET turns on, the SW pin rises. When the high–side MOSFET is fully turned on, SW will settle to VIN and BST will settle to VIN + VCC (excluding parasitic ringing).

#### **Bootstrap Circuit**

The bootstrap circuit relies on an external charge storage capacitor ( $C_{BST}$ ) and an integrated diode to provide current to the high–side driver. A multi–layer ceramic capacitor (MLCC) with a value greater than 100 nF should be used for  $C_{BST}$ .

#### **Power Supply Decoupling**

The NCP81155 can source and sink relatively large currents to the gate pins of the MOSFETs. In order to maintain a constant and stable supply voltage, a low–ESR capacitor should be placed near the VCC and GND pins. A MLCC between 1  $\mu$ F and 4.7  $\mu$ F is typically used.

#### **Undervoltage Lockout**

DRVH and DRVL are low until VCC reaches the VCC UVLO threshold, typically 4.35 V. Once VCC reaches this threshold, the PWM signal will control DRVH and DRVL. There is a 200 mV hysteresis on VCC UVLO. There are pull-down resistors on DRVH and DRVL to prevent the gates of the MOSFETs from accumulating enough charge to turn on when the driver is powered off.

#### **Bi-Directional EN Signal**

The Enable pin (EN) is used to disable the DRVH and DRVL outputs to prevent power transfer. When EN is above the  $EN_{HI}$  threshold, DRVH and DRVL change their

states according to the PWM input. A UVLO fault turns on the internal MOSFET that pulls the EN pin towards ground. By connecting EN to the DRON pin of a controller, the controller is alerted when the driver encounters a fault condition.

#### **PWM** Input

Switching PWM between logic-high and logic-low states will allow the driver to operate in continuous conduction mode as long as VCC is greater than the UVLO threshold and EN is high. The threshold limits are specified in the electrical characteristics table in this datasheet. Refer to Figure 2 for the gate timing diagrams.

When PWM is set above PWM<sub>HI</sub>, DRVL will first turn off after a propagation delay of  $tpdl_{DRVL}$ . To ensure non–overlap between DRVL and DRVH, there is a delay of  $tpdh_{DRVH}$  from the time DRVL falls to 1 V, before DRVH is allowed to turn on.

When PWM falls below PWM<sub>LO</sub>, DRVH will first turn off after a propagation delay of  $tpdl_{DRVH}$ . To ensure non–overlap between DRVH and DRVL, there is a delay of  $tpdh_{DRVL}$  from the time DRVH – SW falls to 1 V, before DRVL is allowed to turn on.

#### **Thermal Considerations**

As power in the NCP81155 increases, it might become necessary to provide some thermal relief. The maximum power dissipation supported by the device is dependent upon board design and layout. Mounting pad configuration on the PCB, the board material, and the ambient temperature affect the rate of junction temperature rise for the part. When the NCP81155 has good thermal conductivity through the PCB, the junction temperature will be relatively low with high power applications. The maximum dissipation the NCP81155 can handle is given by:

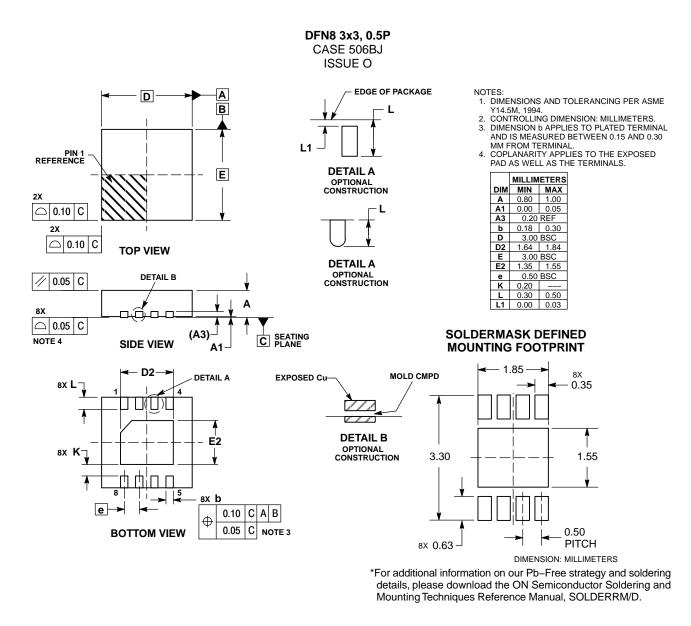
$$\mathsf{P}_{\mathsf{D}(\mathsf{MAX})} = \frac{[\mathsf{T}_{\mathsf{J}(\mathsf{MAX})} - \mathsf{T}_{\mathsf{A}}]}{\mathsf{R}_{\mathsf{\theta}\mathsf{J}\mathsf{A}}} \tag{eq. 1}$$

Since  $T_J$  is not recommended to exceed 150°C, the NCP81155, soldered on to a 645 mm<sup>2</sup> copper area, using 1 oz. copper and FR4, can dissipate up to 2.3 W when the ambient temperature ( $T_A$ ) is 25°C. The power dissipated by the NCP81155 can be calculated from the following equation:

$$\label{eq:P_D} \textbf{P}_{D} \approx \textbf{V}_{CC} \times [(\textbf{n}_{HS} \times \textbf{Q}\textbf{g}_{HS} + \textbf{n}_{LS} \times \textbf{Q}\textbf{g}_{LS}) \times \textbf{f} + \textbf{I}_{standby}] \tag{eq. 2}$$

Where  $n_{HS}$  and  $n_{LS}$  are the number of high-side and low-side FETs, respectively,  $Qg_{HS}$  and  $Qg_{LS}$  are the gate charges of the high-side and low-side FETs, respectively and *f* is the switching frequency of the converter.

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